

QUERY CONTROL FORM			RTIS USE ONLY		
Application No.	09986137	Prepared by	ewc	Tracking Number	05879275
Examiner-GAU	Lee	Date	2/11/04	Week Date	12-22-03
	2881	No. of queries	- 1 -	IFW	

JACKET			
a. Serial No.	f. Foreign Priority	k. Print Claim(s)	p. PTO-1449
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

SPECIFICATION		
a. Page Missing	<p>① MESSAGE</p> <p>PTO-1449 Please either initial or line through citations see attached</p> <p>② Specification and other 1449 forms are illegible</p> <p>Please provide clear copy</p> <p>Thank you</p> <p>ewc</p>	
b. Text Continuity		
c. Holes through Data		
d. Other Missing Text		
e. Illegible Text		
f. Duplicate Text		
g. Brief Description		
h. Sequence Listing		
i. Appendix		
j. Amendments		
k. Other		
CLAIMS		
a. Claim(s) Missing		<p>RESPONSE</p>
b. Improper Dependency		
c. Duplicate Numbers		
d. Incorrect Numbering		
e. Index Disagrees		
f. Punctuation		
g. Amendments		
h. Bracketing		
i. Missing Text		
j. Duplicate Text		
k. Other		



SHEET 1 OF 1

INFORMATION DISCLOSURE  
CITATION IN AN  
APPLICATIONATTY. DOCKET NO.  
49959-220SERIAL NO.  
09/986,137APPLICANT  
Gilad ALMOGY, et al.FILING DATE  
November 07, 2001GROUP  
2881

(PTO-1449)

## U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US 5,080,803	02/25/92	Ames et al.	
		US 5,239,178	08/24/93	Demdinger et al.	
		US 4,500,202	02/19/85	Smyth	
		US 3,883,354	06/15/76	Feldman et al.	
		US 5,198,900	03/23/93	Pettersen	
		US 8,108,090	08/22/00	Ishihara	
		US 5,783,833	07/21/98	Sugaya et al.	
		US 6,208,411	03/27/01	Vaez-Iravani	
		US			

## FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes - Number - Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No
		EP 1058111 A2	12/08/00	Europe			
		WO 97/34171	09/18/97	PCT			
		WO 99/48041	09/23/99	PCT			
		EP 1138254 A1	10/04/01	Europe			

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
		"Quality control and process observation for the micro assembly process", Tilo Pfeifer et al, MEASUREMENT, INSTITUTE OF MEASUREMENT AND CONTROL, vol. 30, no. 1, July 2001, pp. 1-18.

EXAMINER

DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 809. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.